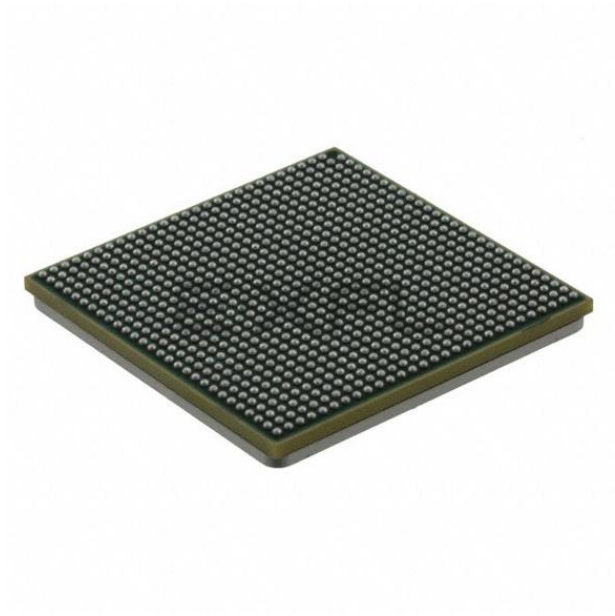

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Understanding Embedded - DSP (Digital Signal Processors)

Embedded - DSP (Digital Signal Processors) are specialized microprocessors designed to perform complex mathematical computations on digital signals in real-time. Unlike general-purpose processors, DSPs are optimized for high-speed numeric processing tasks, making them ideal for applications that require efficient and precise manipulation of digital data. These processors are fundamental in converting and processing signals in various forms, including audio, video, and communication signals, ensuring that data is accurately interpreted and utilized in embedded systems.

Applications of Embedded - DSP (Digital Signal Processors)

Details	
Product Status	Obsolete
Type	SC3850 Quad Core
Interface	Ethernet, I²C, PCI, RGMII, Serial RapidIO, SGMII, SPI, UART/USART
Clock Rate	800MHz
Non-Volatile Memory	ROM (96kB)
On-Chip RAM	576kB
Voltage - I/O	2.50V
Voltage - Core	1.00V
Operating Temperature	-40°C ~ 105°C (TJ)
Mounting Type	Surface Mount
Package / Case	783-BBGA, FCBGA
Supplier Device Package	783-FCPBGA (29x29)
Purchase URL	https://www.e-xfl.com/product-detail/nxp-semiconductors/msc8254tvt800b

Table 1. Signal List by Ball Number (continued)

Ball Number	Signal Name[1,2]	Pin Type[10]	Power Rail Name
B9	M2A13	O	GVDD2
B10	VSS	Ground	N/A
B11	GVDD2	Power	N/A
B12	$\overline{\text{M2CS1}}$	O	GVDD2
B13	VSS	Ground	N/A
B14	GVDD2	Power	N/A
B15	M2DQ35	I/O	GVDD2
B16	VSS	Ground	N/A
B17	GVDD2	Power	N/A
B18	M2DQ51	I/O	GVDD2
B19	VSS	Ground	N/A
B20	GVDD2	Power	N/A
B21	Reserved	NC	—
B22	Reserved	NC	—
B23	SR1_TXD0	O	SXPVDD1
B24	$\overline{\text{SR1\_TXD0}}$	O	SXPVDD1
B25	SXCVDD1	Power	N/A
B26	SXCVSS1	Ground	N/A
B27	$\overline{\text{SR1\_RXD0}}$	I	SXCVDD1
B28	SR1_RXD0	I	SXCVDD1
C1	M2DQ28	I/O	GVDD2
C2	M2DM3	O	GVDD2
C3	M2DQ26	I/O	GVDD2
C4	M2ECC4	I/O	GVDD2
C5	M2DM8	O	GVDD2
C6	M2ECC2	I/O	GVDD2
C7	M2CKE1	O	GVDD2
C8	M2CK0	O	GVDD2
C9	$\overline{\text{M2CK0}}$	O	GVDD2
C10	M2BA1	O	GVDD2
C11	M2A1	O	GVDD2
C12	$\overline{\text{M2WE}}$	O	GVDD2
C13	M2DQ37	I/O	GVDD2
C14	M2DM4	O	GVDD2
C15	M2DQ36	I/O	GVDD2
C16	M2DQ32	I/O	GVDD2
C17	M2DQ55	I/O	GVDD2
C18	M2DM6	O	GVDD2
C19	M2DQ53	I/O	GVDD2
C20	M2DQ52	I/O	GVDD2
C21	Reserved	NC	—
C22	SR1_IMP_CAL_RX	I	SXCVDD1
C23	SXPVSS1	Ground	N/A
C24	SXPVDD1	Power	N/A
C25	SR1_REF_CLK	I	SXCVDD1
C26	$\overline{\text{SR1\_REF\_CLK}}$	I	SXCVDD1

Table 1. Signal List by Ball Number (continued)

Ball Number	Signal Name[1,2]	Pin Type[10]	Power Rail Name
N23	SR2_TXD2/PE_TXD2/SG1_TX[4]	O	SXPVDD2
N24	$\overline{\text{SR2\_TXD2}}$/$\overline{\text{PE\_TXD2}}$/$\overline{\text{SG1\_TX}}$[4]	O	SXPVDD2
N25	SXCVDD2	Power	N/A
N26	SXCVSS2	Ground	N/A
N27	$\overline{\text{SR2\_RXD2}}$/$\overline{\text{PE\_RXD2}}$/$\overline{\text{SG1\_RX}}$[4]	I	SXCVDD2
N28	SR2_RXD2/PE_RXD2/SG1_RX[4]	I	SXCVDD2
P1	CLKIN	I	QVDD
P2	EE0	I	QVDD
P3	QVDD	Power	N/A
P4	VSS	Ground	N/A
P5	STOP_BS	I	QVDD
P6	QVDD	Power	N/A
P7	VSS	Ground	N/A
P8	PLL0_AVDD[9]	Power	VDD
P9	PLL2_AVDD[9]	Power	VDD
P10	VSS	Ground	N/A
P11	VDD	Power	N/A
P12	VSS	Ground	N/A
P13	VDD	Power	N/A
P14	VSS	Ground	N/A
P15	VSS	Ground	N/A
P16	VSS	Ground	N/A
P17	VSS	Ground	N/A
P18	VSS	Ground	N/A
P19	VDD	Power	N/A
P20	Reserved	NC	—
P21	Reserved	NC	—
P22	Reserved	NC	—
P23	SXPVDD2	Power	N/A
P24	SXPVSS2	Ground	N/A
P25	SR2_PLL_AGND[9]	Ground	SXCVSS2
P26	SR2_PLL_AVDD[9]	Power	SXCVDD2
P27	SXCVSS2	Ground	N/A
P28	SXCVDD2	Power	N/A
R1	VSS	Ground	N/A
R2	$\overline{\text{NMI}}$	I	QVDD
R3	$\overline{\text{NMI\_OUT}}$[6]	O	QVDD
R4	$\overline{\text{HRESET}}$[6,7]	I/O	QVDD
R5	$\overline{\text{INT\_OUT}}$[6]	O	QVDD
R6	EE1	O	QVDD
R7	VSS	Ground	N/A
R8	PLL1_AVDD[9]	Power	VDD
R9	VSS	Ground	N/A
R10	VDD	Power	N/A
R11	VSS	Non-user	N/A
R12	VDD	Power	N/A

Table 1. Signal List by Ball Number (continued)

Ball Number	Signal Name[1,2]	Pin Type[10]	Power Rail Name
V21	$\overline{\text{RCW\_LSEL\_3}}$/RC20	I/O	NVDD
V22	$\overline{\text{RCW\_LSEL\_2}}$/RC19	I/O	NVDD
V23	SXPVDD2	Power	N/A
V24	SXPVSS2	Ground	N/A
V25	$\overline{\text{RCW\_LSEL\_1}}$/RC18	I/O	NVDD
V26	RC21	I	NVDD
V27	SXCVDD2	Power	N/A
V28	SXCVSS2	Ground	N/A
W1	VSS	Ground	N/A
W2	GVDD1	Power	N/A
W3	M1DM1	O	GVDD1
W4	VSS	Ground	N/A
W5	GVDD1	Power	N/A
W6	M1DQ0	I/O	GVDD1
W7	VSS	Ground	N/A
W8	GVDD1	Power	N/A
W9	M1DQ5	I/O	GVDD1
W10	VDD	Power	N/A
W11	VSS	Ground	N/A
W12	VDD	Power	N/A
W13	VSS	Ground	N/A
W14	VDD	Power	N/A
W15	VSS	Ground	N/A
W16	VDD	Power	N/A
W17	VSS	Ground	N/A
W18	VDD	Power	N/A
W19	VSS	Ground	N/A
W20	VSS	Ground	N/A
W21	$\overline{\text{RCW\_LSEL0}}$/RC17	I/O	NVDD
W22	GPIO19/SPI_MISO[5,8]	I/O	NVDD
W23	VSS	Ground	N/A
W24	NVDD	Power	N/A
W25	GPIO11/$\overline{\text{IRQ11}}$/RC11[5,8]	I/O	NVDD
W26	GPIO3/DRQ1/$\overline{\text{IRQ3}}$/RC3[5,8]	I/O	NVDD
W27	GPIO7/$\overline{\text{IRQ7}}$/RC7[5,8]	I/O	NVDD
W28	GPIO2/$\overline{\text{IRQ2}}$/RC2[5,8]	I/O	NVDD
Y1	M1DQS1	I/O	GVDD1
Y2	$\overline{\text{M1DQS1}}$	I/O	GVDD1
Y3	M1DQ10	I/O	GVDD1
Y4	M1DQ11	I/O	GVDD1
Y5	M1DQ14	I/O	GVDD1
Y6	M1DQ23	I/O	GVDD1
Y7	M1ODT0	O	GVDD1
Y8	M1A12	O	GVDD1
Y9	M1A14	O	GVDD1
Y10	VSS	Ground	N/A

Table 1. Signal List by Ball Number (continued)

Ball Number	Signal Name[1,2]	Pin Type[10]	Power Rail Name
AB1	$\overline{\text{M1DQS2}}$	I/O	GVDD1
AB2	M1DQS2	I/O	GVDD1
AB3	M1DQ19	I/O	GVDD1
AB4	M1DM2	O	GVDD1
AB5	M1DQ21	I/O	GVDD1
AB6	M1DQ22	I/O	GVDD1
AB7	M1CKE0	O	GVDD1
AB8	M1A11	O	GVDD1
AB9	M1A7	O	GVDD1
AB10	$\overline{\text{M1CK2}}$	O	GVDD1
AB11	M1APAR_OUT	O	GVDD1
AB12	M1ODT1	O	GVDD1
AB13	$\overline{\text{M1APAR\_IN}}$	I	GVDD1
AB14	M1DQ43	I/O	GVDD1
AB15	M1DM5	O	GVDD1
AB16	M1DQ44	I/O	GVDD1
AB17	M1DQ40	I/O	GVDD1
AB18	M1DQ59	I/O	GVDD1
AB19	M1DM7	O	GVDD1
AB20	M1DQ60	I/O	GVDD1
AB21	VSS	Ground	N/A
AB22	GPIO31/I2C_SDA[5,8]	I/O	NVDD
AB23	GPIO27/TMR4/RCW_SRC0[5,8]	I/O	NVDD
AB24	GPIO25/TMR2/RCW_SRC1[5,8]	I/O	NVDD
AB25	GPIO24/TMR1/RCW_SRC2[5,8]	I/O	NVDD
AB26	GPIO10/$\overline{\text{IRQ10}}$/RC10[5,8]	I/O	NVDD
AB27	GPIO5/$\overline{\text{IRQ5}}$/RC5[5,8]	I/O	NVDD
AB28	GPIO0/$\overline{\text{IRQ0}}$/RC0[5,8]	I/O	NVDD
AC1	VSS	Ground	N/A
AC2	GVDD1	Power	N/A
AC3	M1DQ16	I/O	GVDD1
AC4	VSS	Ground	N/A
AC5	GVDD1	Power	N/A
AC6	M1DQ17	I/O	GVDD1
AC7	VSS	Ground	N/A
AC8	GVDD1	Power	N/A
AC9	M1BA2	O	GVDD1
AC10	VSS	Ground	N/A
AC11	GVDD1	Power	N/A
AC12	M1A4	O	GVDD1
AC13	VSS	Ground	N/A
AC14	GVDD1	Power	N/A
AC15	M1DQ42	I/O	GVDD1
AC16	VSS	Ground	N/A
AC17	GVDD1	Power	N/A
AC18	M1DQ58	I/O	GVDD1

Table 1. Signal List by Ball Number (continued)

Ball Number	Signal Name[1,2]	Pin Type[10]	Power Rail Name
AF27	TDM2TDT/GE1_TX_CLK[3]	I/O	NVDD
AF28	TDM3RSN/GE1_RD1[3]	I/O	NVDD
AG1	M1DQ24	I/O	GVDD1
AG2	GVDD1	Power	N/A
AG3	M1DQ25	I/O	GVDD1
AG4	VSS	Ground	N/A
AG5	GVDD1	Power	N/A
AG6	M1ECC1	I/O	GVDD1
AG7	VSS	Ground	N/A
AG8	GVDD1	Power	N/A
AG9	M1A13	O	GVDD1
AG10	VSS	Ground	N/A
AG11	GVDD1	Power	N/A
AG12	$\overline{\text{M1CS1}}$	O	GVDD1
AG13	VSS	Ground	N/A
AG14	GVDD1	Power	N/A
AG15	M1DQ35	I/O	GVDD1
AG16	VSS	Ground	N/A
AG17	GVDD1	Power	N/A
AG18	M1DQ51	I/O	GVDD1
AG19	VSS	Ground	N/A
AG20	GVDD1	Power	N/A
AG21	NVDD	Power	N/A
AG22	TDM1TSN/GE2_TD1[3]	I/O	NVDD
AG23	TDM1RDT/GE2_TX_CLK[3]	I/O	NVDD
AG24	TDM0TCK/GE2_GTX_CLK[3]	I/O	NVDD
AG25	TDM1TDT/GE2_TD0[3]	I/O	NVDD
AG26	VSS	Ground	N/A
AG27	NVDD	Power	N/A
AG28	TDM3RDT/GE1_RD0[3]	I/O	NVDD
AH1	Reserved.	NC	—
AH2	$\overline{\text{M1DQS3}}$	I/O	GVDD1
AH3	M1DQS3	I/O	GVDD1
AH4	M1ECC0	I/O	GVDD1
AH5	$\overline{\text{M1DQS8}}$	I/O	GVDD1
AH6	M1DQS8	I/O	GVDD1
AH7	M1A5	O	GVDD1
AH8	$\overline{\text{M1CK1}}$	O	GVDD1
AH9	M1CK1	O	GVDD1
AH10	$\overline{\text{M1CS0}}$	O	GVDD1
AH11	M1BA0	O	GVDD1
AH12	$\overline{\text{M1CAS}}$	O	GVDD1
AH13	M1DQ34	I/O	GVDD1
AH14	$\overline{\text{M1DQS4}}$	I/O	GVDD1
AH15	M1DQS4	I/O	GVDD1
AH16	M1DQ50	I/O	GVDD1

2.5.1.2 DDR3 (1.5V) SDRAM DC Electrical Characteristics

Table 7 provides the recommended operating conditions for the DDR SDRAM controller when interfacing to DDR3 SDRAM.

Note: At recommended operating conditions (see Table 3) with V_{DDDDR} = 1.5 V.

Table 7. DDR3 SDRAM Interface DC Electrical Characteristics

Parameter/Condition	Symbol	Min	Max	Unit	Notes
I/O reference voltage	MV_{REF}	$0.49 \times V_{DDDDR}$	$0.51 \times V_{DDDDR}$	V	2,3,4
Input high voltage	V_{IH}	MV_{REF} + 0.100	V_{DDDDR}	V	5
Input low voltage	V_{IL}	GND	MV_{REF} – 0.100	V	5
I/O leakage current	I_{OZ}	–50	50	µA	6

Notes:
1. V_{DDDDR} is expected to be within 50 mV of the DRAM V_{DD} at all times. The DRAM and memory controller can use the same or different sources.
2. MV_{REF} is expected to be equal to $0.5 \times V_{DDDDR}$, and to track V_{DDDDR} DC variations as measured at the receiver. Peak-to-peak noise on MV_{REF} may not exceed ±1% of the DC value.
3. V_{TT} is not applied directly to the device. It is the supply to which far end signal termination is made and is expected to be equal to MV_{REF} with a minimum value of MV_{REF} – 0.4 and a maximum value of MV_{REF} + 0.04 V. V_{TT} should track variations in the DC-level of MV_{REF}.
4. The voltage regulator for MV_{REF} must be able to supply up to 250 µA.
5. Input capacitance load for DQ, DQS, and $\overline{DQS}$ signals are available in the IBIS models.
6. Output leakage is measured with all outputs are disabled, $0 V \le V_{OUT} \le V_{DDDDR}$.

2.5.1.3 DDR2/DDR3 SDRAM Capacitance

Table 8 provides the DDR controller interface capacitance for DDR2 and DDR3 memory.

Note: At recommended operating conditions (see Table 3) with V_{DDDDR} = 1.8 V for DDR2 memory or V_{DDDDR} = 1.5 V for DDR3 memory.

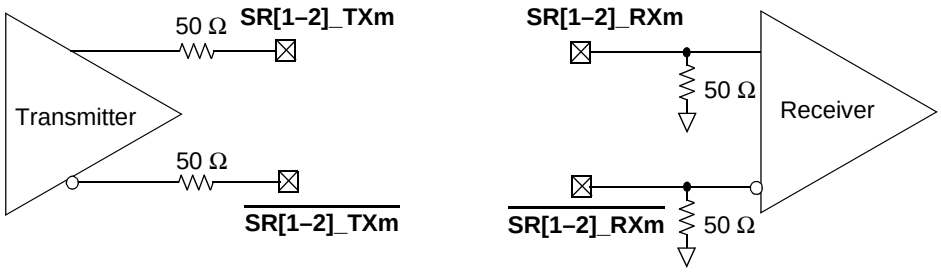
Table 8. DDR2/DDR3 SDRAM Capacitance

Parameter	Symbol	Min	Max	Unit
I/O capacitance: DQ, DQS, $\overline{DQS}$	C_{IO}	6	8	pF
Delta I/O capacitance: DQ, DQS, $\overline{DQS}$	C_{DIO}	—	0.5	pF

Note: Guaranteed by FAB process and micro-construction.

2.5.2.3 SerDes Transmitter and Receiver Reference Circuits

Figure 6 shows the reference circuits for SerDes data lane transmitter and receiver.



Note: The [1–2] indicates the specific SerDes Interface (1 or 2) and the m indicates the specific channel within that interface (0,1,2,3). Actual signals are assigned by the HRCW assignments at reset (see **Chapter 5**, *Reset* in the reference manual for details)

Figure 6. SerDes Transmitter and Receiver Reference Circuits

2.5.3 DC-Level Requirements for SerDes Interfaces

The following subsections define the DC-level requirements for the SerDes reference clocks, the PCI Express data lines, the Serial RapidIO data lines, and the SGMII data lines.

2.5.3.1 DC-Level Requirements for SerDes Reference Clocks

The DC-level requirement for the SerDes reference clock inputs is different depending on the signaling mode used to connect the clock driver chip and SerDes reference clock inputs, as described below:

- Differential Mode
  - The input amplitude of the differential clock must be between 400 mV and 1600 mV differential peak-peak (or between 200 mV and 800 mV differential peak). In other words, each signal wire of the differential pair must have a single-ended swing of less than 800 mV and greater than 200 mV. This requirement is the same for both external DC-coupled or AC-coupled connection.
  - For an external DC-coupled connection, the maximum average current requirements sets the requirement for average voltage (common mode voltage) as between 100 mV and 400 mV. Figure 7 shows the SerDes reference clock input requirement for DC-coupled connection scheme.

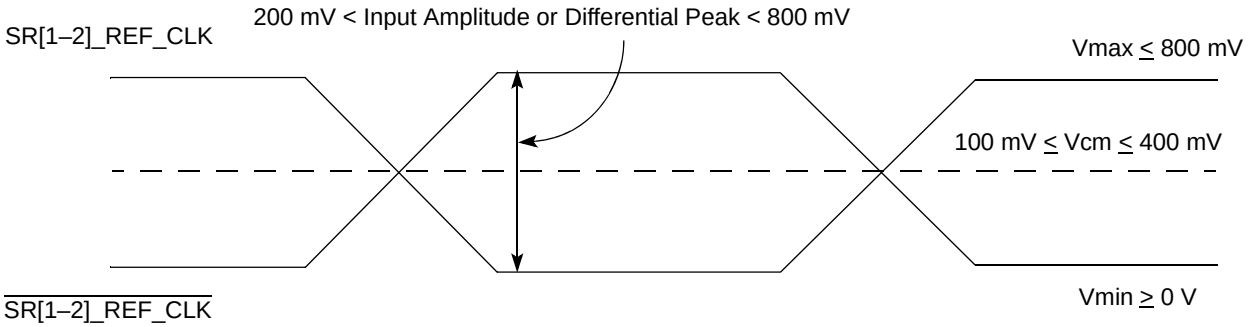


Figure 7. Differential Reference Clock Input DC Requirements (External DC-Coupled)

— For an external AC-coupled connection, there is no common mode voltage requirement for the clock driver. Because the external AC-coupling capacitor blocks the DC-level, the clock driver and the SerDes reference clock receiver operate in different command mode voltages. The SerDes reference clock receiver in this connection scheme has its common mode voltage set to GND_{SXC}. Each signal wire of the differential inputs is allowed to swing below and above the command mode voltage GND_{SXC}. Figure 8 shows the SerDes reference clock input requirement for AC-coupled connection scheme.

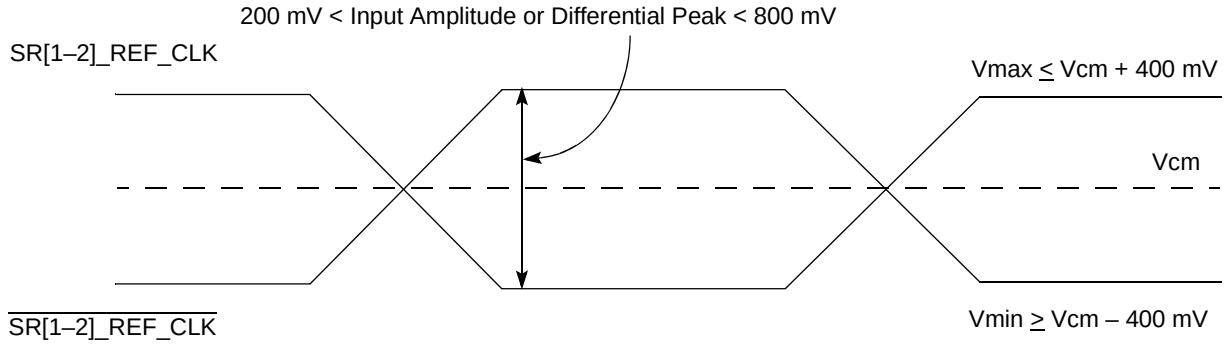


Figure 8. Differential Reference Clock Input DC Requirements (External AC-Coupled)

- Single-Ended Mode
  — The reference clock can also be single-ended. The SR[1–2]_REF_CLK input amplitude (single-ended swing) must be between 400 mV and 800 mV peak-peak (from V_{MIN} to V_{MAX}) with $\overline{\text{SR[1–2]\_REF\_CLK}}$ either left unconnected or tied to ground.
  — The SR[1–2]_REF_CLK input average voltage must be between 200 and 400 mV. Figure 9 shows the SerDes reference clock input requirement for single-ended signalling mode.
  — To meet the input amplitude requirement, the reference clock inputs may need to be DC- or AC-coupled externally. For the best noise performance, the reference of the clock could be DC- or AC-coupled into the unused phase ($\overline{\text{SR[1–2]\_REF\_CLK}}$) through the same source impedance as the clock input (SR[1–2]_REF_CLK) in use.

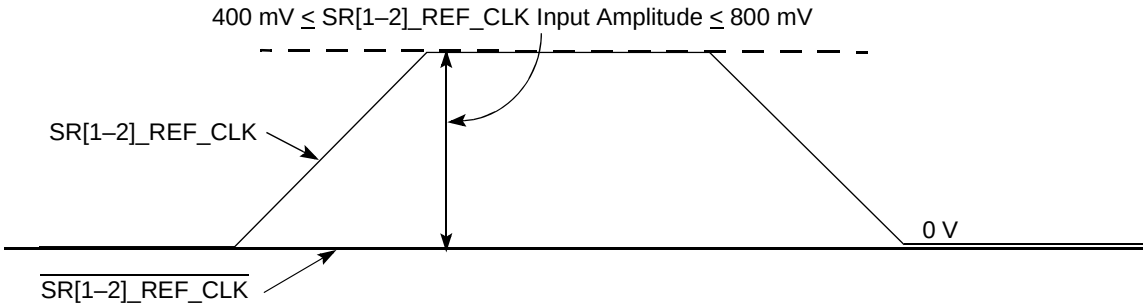


Figure 9. Single-Ended Reference Clock Input DC Requirements

2.5.3.2 DC-Level Requirements for PCI Express Configurations

The DC-level requirements for PCI Express implementations have separate requirements for the Tx and Rx lines. The MSC8254 supports a 2.5 Gbps PCI Express interface defined by the *PCI Express Base Specification, Revision 1.0a*. The transmitter specifications are defined in Table 11 and the receiver specifications are defined in Table 12.

Note: Specifications are valid at the recommended operating conditions listed in Table 3.

Table 11. PCI Express (2.5 Gbps) Differential Transmitter (Tx) Output DC Specifications

Parameter	Symbol	Min	Typical	Max	Units	Notes
Differential peak-to-peak output voltage	$V_{TX-DIFFp-p}$	800	1000	1200	mV	1
De-emphasized differential output voltage (ratio)	$V_{TX-DE-RATIO}$	3.0	3.5	4.0	dB	2
DC differential Tx impedance	$Z_{TX-DIFF-DC}$	80	100	120	Ω	3
Transmitter DC impedance	Z_{TX-DC}	40	50	60	Ω	4

Notes:
1. $V_{TX-DIFFp-p} = 2 \times |V_{TX-D+} - V_{TX-D-}|$ Measured at the package pins with a test load of 50 Ω to GND on each pin.
2. Ratio of the $V_{TX-DIFFp-p}$ of the second and following bits after a transition divided by the $V_{TX-DIFFp-p}$ of the first bit after a transition. Measured at the package pins with a test load of 50 Ω to GND on each pin.
3. Tx DC differential mode low impedance
4. Required Tx D+ as well as D– DC Impedance during all states

Table 12. PCI Express (2.5 Gbps) Differential Receiver (Rx) Input DC Specifications

Parameter	Symbol	Min	Typical	Max	Units	Notes
Differential input peak-to-peak voltage	$V_{RX-DIFFp-p}$	120	1000	1200	mV	1
DC differential Input Impedance	$Z_{RX-DIFF-DC}$	80	100	120	Ω	2
DC input impedance	Z_{RX-DC}	40	50	60	Ω	3
Powered down DC input impedance	$Z_{RX-HIGH-IMP-DC}$	50	—	—	KΩ	4
Electrical idle detect threshold	$V_{RX-IDLE-DET-DIFFp-p}$	65	—	175	mV	5

Notes:
1. $V_{RX-DIFFp-p} = 2 \times |V_{RX-D+} - V_{RX-D-}|$ Measured at the package pins with a test load of 50 Ω to GND on each pin.
2. Rx DC differential mode impedance. Impedance during all LTSSM states. When transitioning from a fundamental reset to detect (the initial state of the LTSSM), there is a 5 ms transition time before the receiver termination values must be met on all unconfigured lanes of a port.
3. Required Rx D+ as well as D– DC Impedance (50 ±20% tolerance). Measured at the package pins with a test load of 50 Ω to GND on each pin. Impedance during all LTSSM states. When transitioning from a fundamental reset to detect (the initial state of the LTSSM), there is a 5 ms transition time before the receiver termination values must be met on all unconfigured lanes of a port.
4. Required Rx D+ as well as D– DC Impedance when the receiver terminations do not have power. The Rx DC common mode impedance that exists when no power is present or fundamental reset is asserted. This helps ensure that the receiver detect circuit does not falsely assume a receiver is powered on when it is not. This term must be measured at 300 mV above the Rx ground.
5. $V_{RX-IDLE-DET-DIFFp-p} = 2 \times |V_{RX-D+} - V_{RX-D-}|$. Measured at the package pins of the receiver

2.5.3.3 DC-Level Requirements for Serial RapidIO Configurations

This sections provided various DC-level requirements for Serial RapidIO Configurations.

Note: Specifications are valid at the recommended operating conditions listed in Table 3.

Table 13. Serial RapidIO Transmitter DC Specifications

Parameter	Symbol	Min	Typical	Max	Units	Notes
Output voltage	V_O	–0.40	—	2.30	V	1
Long run differential output voltage	V_{DIFFPP}	800	—	1600	mVp-p	—
Short run differential output voltage	V_{DIFFPP}	500	—	1000	mVp-p	—

Note: Voltage relative to COMMON of either signal comprising a differential pair.

2.6.2.4 SGMII AC Timing Specifications

Note: Specifications are valid at the recommended operating conditions listed in Table 3.

Transmitter and receiver AC characteristics are measured at the transmitter outputs (SR[1–2]_TX[n] and $\overline{\text{SR[1–2]\_TX}}$[n]) or at the receiver inputs (SR[1–2]_RX[n] and $\overline{\text{SR[1–2]\_RX}}$[n]) as depicted in Figure 19, respectively.

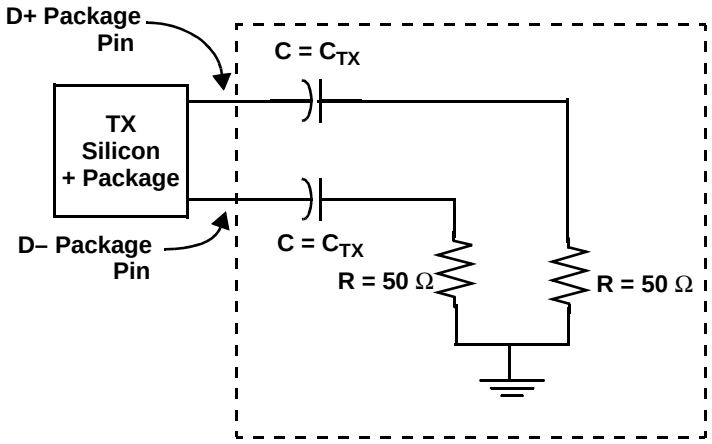


Figure 19. SGMII AC Test/Measurement Load

Table 29 provides the SGMII transmit AC timing specifications. A source synchronous clock is not supported. The AC timing specifications do not include REF_CLK jitter.

Table 29. SGMII Transmit AC Timing Specifications

Parameter	Symbol	Min	Typ	Max	Unit	Notes
Deterministic Jitter	JD	—	—	0.17	UI p-p	—
Total Jitter	JT	—	—	0.35	UI p-p	2
Unit Interval	UI	799.92	800	800.08	ps	1

Notes: **1.** See Figure 18 for single frequency sinusoidal jitter limits
2. Each UI is 800 ps ± 100 ppm.

Table 30 provides the SGMII receiver AC timing specifications. The AC timing specifications do not include REF_CLK jitter.

Table 30. SGMII Receive AC Timing Specifications

Parameter	Symbol	Min	Typ	Max	Unit	Notes
Deterministic Jitter Tolerance	JD	0.37	—	—	UI p-p	1, 2
Combined Deterministic and Random Jitter Tolerance	JDR	0.55	—	—	UI p-p	1, 2
Total Jitter Tolerance	JT	0.65	—	—	UI p-p	1,2
Bit Error Ratio	BER	—	—	10^{-12}	—	—
Unit Interval	UI	799.92	800.00	800.08	ps	3

Notes: **1.** Measured at receiver.
2. Refer to RapidIO™ 1x/4x LP Serial Physical Layer Specification for interpretation of jitter specifications. Also see Figure 18.
3. Each UI is 800 ps ± 100 ppm.

2.6.3 TDM Timing

Table 31 provides the input and output AC timing specifications for the TDM interface.

Table 31. TDM AC Timing Specifications for 62.5 MHz[1]

Parameter	Symbol[2]	Min	Max	Unit
TDMxRCK/TDMxTCK	t_{DM}	16.0	—	ns
TDMxRCK/TDMxTCK high pulse width	t_{DM_HIGH}	7.0	—	ns
TDMxRCK/TDMxTCK low pulse width	t_{DM_LOW}	7.0	—	ns
TDM all input setup time	t_{DMIVKH}	3.6	—	ns
TDMxRD hold time	$t_{DMRDIXKH}$	1.9	—	ns
TDMxTFS/TDMxRFS input hold time	$t_{DMFSIXKH}$	1.9	—	ns
TDMxTCK High to TDMxTD output active	t_{DM_OUTAC}	2.5	—	ns
TDMxTCK High to TDMxTD output valid	$t_{DMTKHOV}$	—	9.8	ns
TDMxTD hold time	$t_{DMTKHOX}$	2.5	—	ns
TDMxTCK High to TDMxTD output high impedance	t_{DM_OUTHI}	—	9.8	ns
TDMxTFS/TDMxRFS output valid	$t_{DMFSKHOV}$	—	9.25	ns
TDMxTFS/TDMxRFS output hold time	$t_{DMFSKHOX}$	2.0	—	ns

Notes:
1. The symbols used for timing specifications follow the pattern $t_{\text{(first two letters of functional block)(signal)(state)(reference)(state)}}$ for inputs and $t_{\text{(first two letters of functional block)(reference)(state)(signal)(state)}}$ for outputs. For example, t_{HIKHOX} symbolizes the output internal timing (HI) for the time t_{serial} memory clock reference (K) goes from the high state (H) until outputs (O) are invalid (X).
2. Output values are based on 30 pF capacitive load.
3. Inputs are referenced to the sampling that the TDM is programmed to use. Outputs are referenced to the programming edge they are programmed to use. Use of the rising edge or falling edge as a reference is programmable. T_{DMxTCK} and T_{DMxRCK} are shown using the rising edge.
4. All values are based on a maximum TDM interface frequency of 62.5 MHz.

Figure 20 shows the TDM receive signal timing.

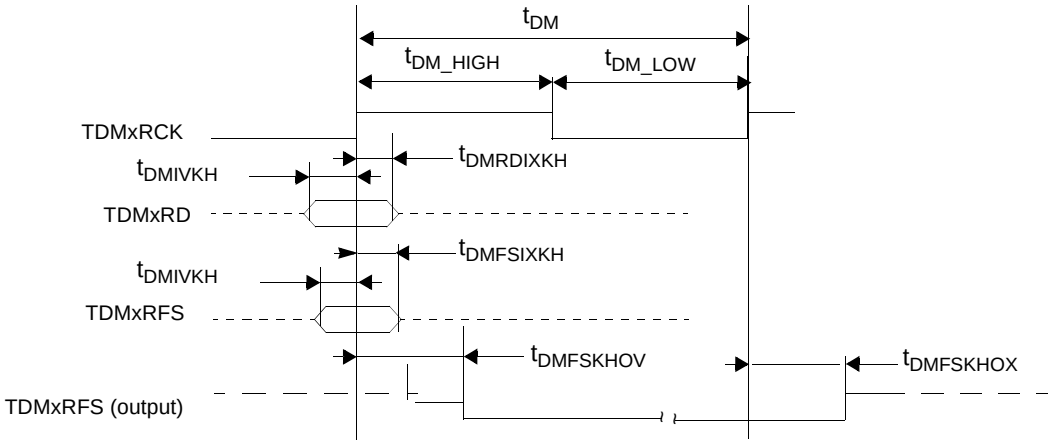


Figure 20. TDM Receive Signals

2.6.5.2 RGMII AC Timing Specifications

Table 34 presents the RGMII AC timing specifications for applications requiring an on-board delayed clock.

Table 34. RGMII at 1 Gbps[2] with On-Board Delay[3] AC Timing Specifications

Parameter/Condition	Symbol	Min	Typ	Max	Unit
Data to clock output skew (at transmitter)[4]	t_{SKEWT}	–-0.5	—	0.5	ns
Data to clock input skew (at receiver) [4]	t_{SKEWR}	1	—	2.6	ns

Notes:
1. At recommended operating conditions with V_{DDIO} of 2.5 V ± 5%.
2. RGMII at 100 Mbps support is guaranteed by design.
3. Program GCR4 as 0x00000000.
4. This implies that PC board design requires clocks to be routed such that an additional trace delay of greater than 1.5 ns and less than 2.0 ns is added to the associated clock signal.

Table 35 presents the RGMII AC timing specification for applications required non-delayed clock on board.

Table 35. RGMII at 1 Gbps[2] with No On-Board Delay[3] AC Timing Specifications

Parameter/Condition	Symbol	Min	Typ	Max	Unit
Data to clock output skew (at transmitter)[4]	t_{SKEWT}	–2.6	—	–1.0	ns
Data to clock input skew (at receiver)[4]	t_{SKEWR}	–0.5	—	0.5	ns

Notes:
1. At recommended operating conditions with V_{DDIO} of 2.5 V ± 5%.
2. RGMII at 100 Mbps support is guaranteed by design.
3. GCR4 should be programmed as 0x000CC330.
4. This implies that PC board design requires clocks to be routed with no additional trace delay

Figure 25 shows the RGMII AC timing and multiplexing diagrams.

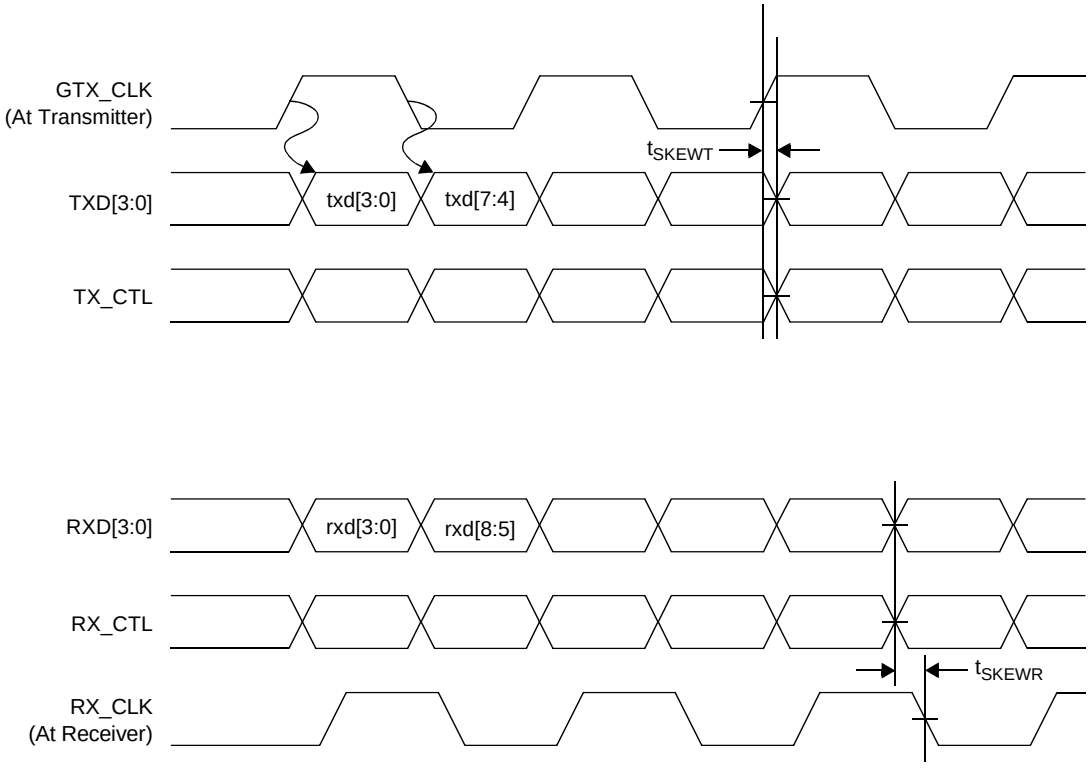


Figure 25. RGMII AC Timing and Multiplexing

2.6.6 SPI Timing

Table 36 lists the SPI input and output AC timing specifications.

Table 36. SPI AC Timing Specifications

Parameter	Symbol [1]	Min	Max	Unit	Note
SPI outputs valid—Master mode (internal clock) delay	t_{NIKHOV}	—	6	ns	2
SPI outputs hold—Master mode (internal clock) delay	t_{NIKHOX}	0.5	—	ns	2
SPI outputs valid—Slave mode (external clock) delay	t_{NEKHOV}	—	12	ns	2
SPI outputs hold—Slave mode (external clock) delay	t_{NEKHOX}	2	—	ns	2
SPI inputs—Master mode (internal clock) input setup time	t_{NIIVKH}	12	—	ns	—
SPI inputs—Master mode (internal clock) input hold time	t_{NIIXKH}	0	—	ns	—
SPI inputs—Slave mode (external clock) input setup time	t_{NEIVKH}	4	—	ns	—
SPI inputs—Slave mode (external clock) input hold time	t_{NEIXKH}	2	—	ns	—

Notes:
1. The symbols used for timing specifications follow the pattern of $t_{\text{(first two letters of functional block)(signal)(state)(reference)(state)}}$ for inputs and $t_{\text{(first two letters of functional block)(reference)(state)(signal)(state)}}$ for outputs. For example, t_{NIKHOX} symbolizes the internal timing (NI) for the time SPICLK clock reference (K) goes to the high state (H) until outputs (O) are invalid (X).
2. Output specifications are measured from the 50% level of the rising edge of SPICLK to the 50% level of the signal. Timings are measured at the pin.

Figure 26 provides the AC test load for the SPI.

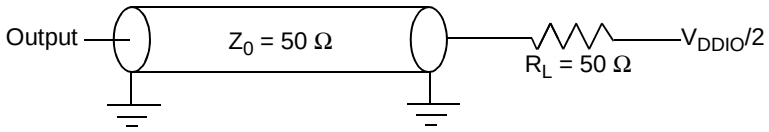
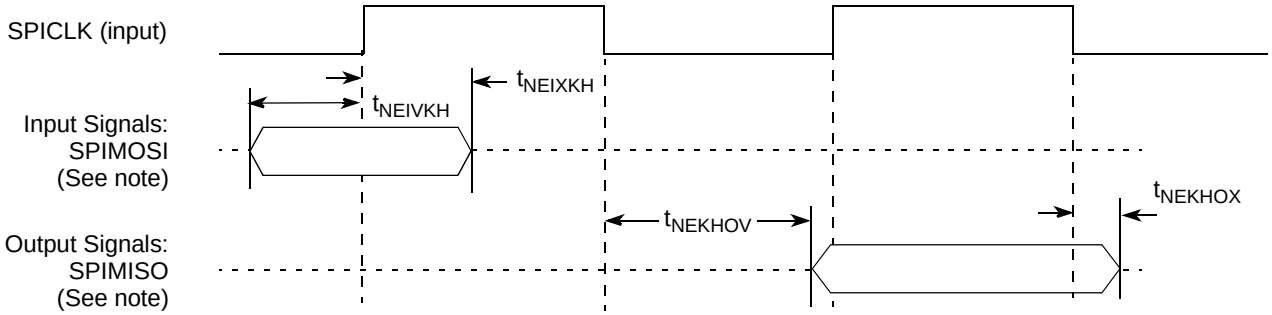


Figure 26. SPI AC Test Load

Figure 27 and Figure 28 represent the AC timings from Table 36. Note that although the specifications generally reference the rising edge of the clock, these AC timing diagrams also apply when the falling edge is the active edge.

Figure 27 shows the SPI timings in slave mode (external clock).



Note: measured with SPMODE[CI] = 0, SPMODE[CP] = 0

Figure 27. SPI AC Timing in Slave Mode (External Clock)

Figure 28 shows the SPI timings in master mode (internal clock).

2.6.7 Asynchronous Signal Timing

Table 35 lists the asynchronous signal timing specifications.

Table 37. Signal Timing

Characteristics	Symbol	Type	Min
Input	t_{IN}	Asynchronous	One CLKIN cycle
Output	t_{OUT}	Asynchronous	Application dependent
Note: Input value relevant for EE0, $\overline{\text{IRQ}}$[15–0], and $\overline{\text{NMI}}$ only.			

The following interfaces use the specified asynchronous signals:

- *GPIO*. Signals GPIO[31–0], when used as GPIO signals, that is, when the alternate multiplexed special functions are not selected.

Note: When used as a general purpose input (GPI), the input signal should be driven until it is acknowledged by the MSC8254 device, that is, when the expected input value is read from the GPIO data register.

- *EE port.* Signals EE0, EE1.
- *Boot function*. Signal STOP_BS.
- *I^2C interface*. Signals I2C_SCL and I2C_SDA.
- *Interrupt inputs*. Signals $\overline{\text{IRQ}}$[15–0] and $\overline{\text{NMI}}$.
- *Interrupt outputs*. Signals $\overline{\text{INT\_OUT}}$ and $\overline{\text{NMI\_OUT}}$ (minimum pulse width is 32 ns).

2.6.8 JTAG Signals

Table 38 lists the JTAG timing specifications shown in Figure 29 through Figure 32.

Table 38. JTAG Timing

Characteristics	Symbol	All frequencies		Unit
		Min	Max	
TCK cycle time	t_{TCKX}	36.0	—	ns
TCK clock high phase measured at $V_M = V_{DDIO}/2$	t_{TCKH}	15.0	—	ns
Boundary scan input data setup time	t_{BSVKH}	0.0	—	ns
Boundary scan input data hold time	t_{BSXKH}	15.0	—	ns
TCK fall to output data valid	t_{TCKHOV}	—	20.0	ns
TCK fall to output high impedance	t_{TCKHOZ}	—	24.0	ns
TMS, TDI data setup time	t_{TDIVKH}	0.0	—	ns
TMS, TDI data hold time	t_{TDIXKH}	5.0	—	ns
TCK fall to TDO data valid	t_{TDOHOV}	—	10.0	ns
TCK fall to TDO high impedance	t_{TDOHOZ}	—	12.0	ns
$\overline{\text{TRST}}$ assert time	t_{TRST}	100.0	—	ns
Note: All timings apply to OnCE module data transfers as well as any other transfers via the JTAG port.				

Figure 29 shows the test clock input timing diagram

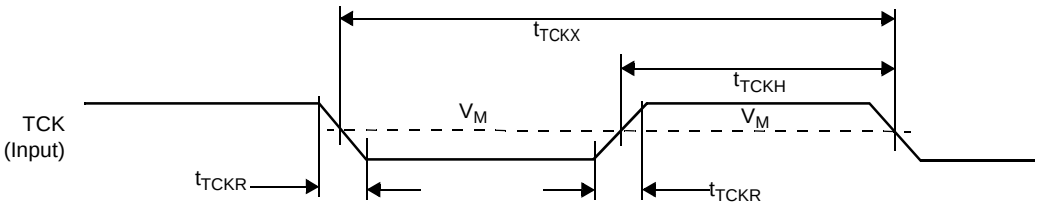


Figure 29. Test Clock Input Timing

3 Hardware Design Considerations

The following sections discuss areas to consider when the MSC8254 device is designed into a system.

3.1 Power Supply Ramp-Up Sequence

The following subsections describe the required device initialization sequence.

3.1.1 Clock, Reset, and Supply Coordination

Starting the device requires coordination between several inputs including: clock, reset, and power supplies. Follow this guidelines when starting up an MSC8254 device:

- $\overline{\text{PORESET}}$ and $\overline{\text{TRST}}$ must be asserted externally for the duration of the supply ramp-up, using the V_{DDIO} supply. $\overline{\text{TRST}}$ deassertion does not have to be synchronized with $\overline{\text{PORESET}}$ deassertion. However, $\overline{\text{TRST}}$ must be deasserted before normal operation begins to ensure correct functionality of the device.
- CLKIN should toggle at least 32 cycles before $\overline{\text{PORESET}}$ deassertion to guarantee correct device operation. The 32 cycles should only be counted from the time after V_{DDIO} reaches its nominal value (see timing 1 in Figure 33).
- CLKIN should either be stable low during ramp-up of V_{DDIO} supply (and start its swings after ramp-up) or should swing within V_{DDIO} range during V_{DDIO} ramp-up, so its amplitude grows as V_{DDIO} grows during ramp-up.

Figure 33 shows a sequence in which V_{DDIO} ramps-up after V_{DD} and CLKIN begins to toggle with the raise of V_{DDIO} supply.

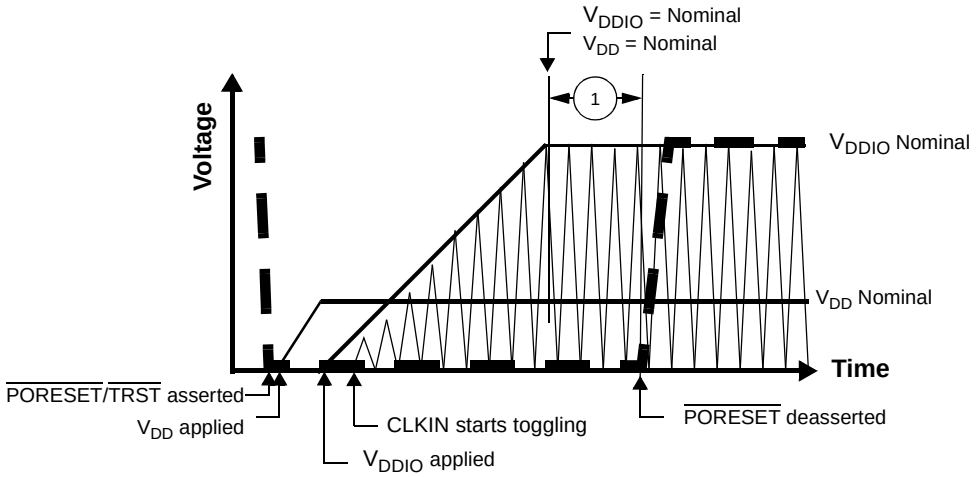


Figure 33. Supply Ramp-Up Sequence with V_{DD} Ramping Before V_{DDIO} and CLKIN Starting With V_{DDIO}

Note: For details on power-on reset flow and duration, see the *Reset* chapter in the *MSC8254 Reference Manual*.

3.1.2 Power-On Ramp Time

This section describes the AC electrical specification for the power-on ramp rate requirements for all voltage supplies (including GVDD/SXPVDD/SXCVDD/QVDD/GVDD/NVDD, all VDD supplies, MVREF, and all AVDD supplies). Controlling the power-on ramp time is required to avoid falsely triggering the ESD circuitry. Table 39 defines the power supply ramp time specification.

Table 39. Power Supply Ramp Rate

Parameter	Min	Max	Unit
Required ramp rate.	—	36000	V/s

Notes:
1. Ramp time is specified as a linear ramp from 10% to 90% of nominal voltage of the specific voltage supply. If the ramp is non-linear (for example, exponential), the maximum rate of change from 200 to 500 mV is the most critical because this range might falsely trigger the ESD circuitry.
2. Required over the full recommended operating temperature range (see Table 3).
3. All supplies must be at their stable values within 50 ms.
4. The GVDD pins can be held low on the application board at powerup. If GVDD is not held low, then GVDD will rise to a voltage level that depends on the board-level impedance-to-ground. If the impedance is high (that is, infinite), then theoretically, GVDD can rise up close to the VDD levels.

3.1.3 Power Supply Guidelines

Use the following guidelines for power-up sequencing:

- Couple M3VDD with the VDD power rail using an extremely low impedance path.
- Couple inputs PLL1_AVDD, PLL2_AVDD and PLL3_AVDD with the VDD power rail using an RC filter (see Figure 37).
- There is no dependency in power-on/power-off sequence between the GVDD1, GVDD2, NVDD, and QVDD power rails.
- Couple inputs M1VREF and M2VREF with the GVDD1 and GVDD2 power rails, respectively. They should rise at the same time as or after their respective power rail.
- There is no dependency between RapidIO supplies: SXCVDD1, SXCVDD2, SXPVDD1 and SXPVDD2 and other MSC8254 supplies in the power-on/power-off sequence
- Couple inputs SR1_PLL_AVDD and SR2_PLL_AVDD with SXCVDD1 and SXCVDD2 power rails, respectively, using an RC filter (see Figure 38).

External voltage applied to any input line must not exceed the I/O supply voltage related to this line by more than 0.6 V at any time, including during power-up. Some designs require pull-up voltages applied to selected input lines during power-up for configuration purposes. This is an acceptable exception to the rule during start-up. However, each such input can draw up to 80 mA per input pin per MSC8254 device in the system during power-up. An assertion of the inputs to the high voltage level before power-up should be with slew rate less than 4 V/ns.

The device power rails should rise in the following sequence:

1. VDD (and all coupled supplies)

2. After the above rails rise to 90% of their nominal voltage, the following I/O power rails may rise in any sequence (see Figure 34): QVDD, NVDD, GVDD1, and GVDD2.

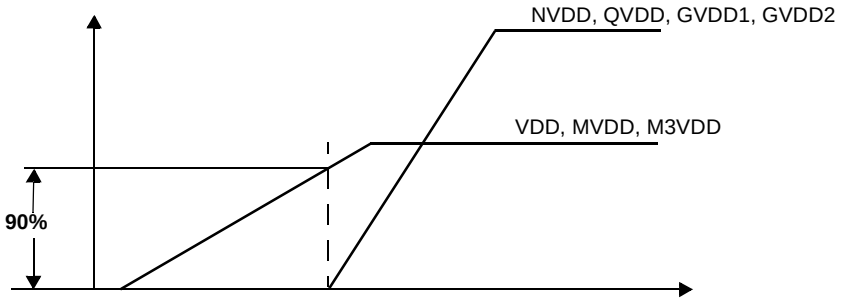


Figure 34. Supply Ramp-Up Sequence

Notes: **1.** If the M3 memory is not used, M3VDD can be tied to GND.
2. If the HSSI port1 is not used, SXCVDD1and SXPVDD1 must be connected to the designated power supplies.
3. If the HSSI port2 is not used, SXCVDD2 and SXPVDD2 must be connected to the designated power supplies.
4. If the DDR port 1 interface is not used, it is recommended that GVDD1 be left unconnected.
5. If the DDR port 2 interface is not used, it is recommended that GVDD2 be left unconnected.

3.1.4 Reset Guidelines

When a debugger is not used, implement the connection scheme shown in Figure 35.

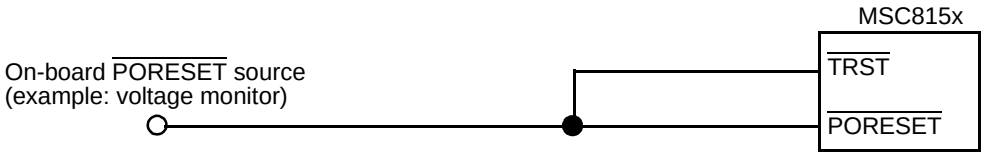


Figure 35. Reset Connection in Functional Application

When a debugger is used, implement the connection scheme shown in Figure 36.

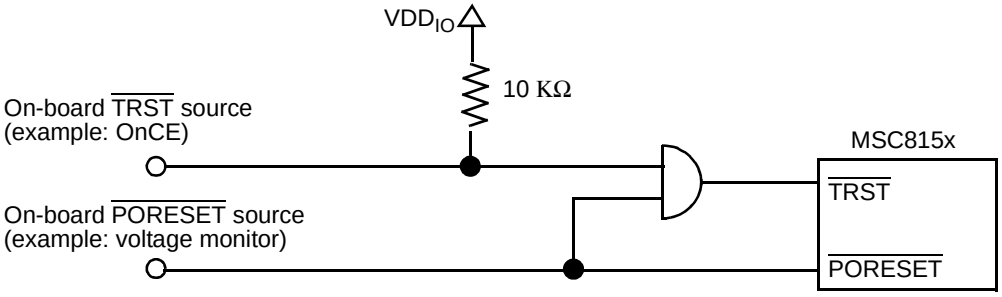


Figure 36. Reset Connection in Debugger Application

3.5 Connectivity Guidelines

Note: Although the package actually uses a ball grid array, the more conventional term pin is used to denote signal connections in this discussion.

First, select the pin multiplexing mode to allocate the required I/O signals. Then use the guidelines presented in the following subsections for board design and connections. The following conventions are used in describing the connectivity requirements:

1. GND indicates using a 10 kΩ pull-down resistor (recommended) or a direct connection to the ground plane. Direct connections to the ground plane may yield DC current up to 50 mA through the I/O supply that adds to overall power consumption.
2. V_{DD} indicates using a 10 kΩ pull-up resistor (recommended) or a direct connection to the appropriate power supply. Direct connections to the supply may yield DC current up to 50 mA through the I/O supply that adds to overall power consumption.
3. Mandatory use of a pull-up or pull-down resistor is clearly indicated as “pull-up/pull-down.” For buses, each pin on the bus should have its own resistor.
4. NC indicates “not connected” and means do not connect anything to the pin.
5. The phrase “in use” indicates a typical pin connection for the required function.

Note: Please see recommendations #1 and #2 as mandatory pull-down or pull-up connection for unused pins in case of subset interface connection.

3.5.1 DDR Memory Related Pins

This section discusses the various scenarios that can be used with either of the MSC8254 DDR ports.

Note: The signal names in Table 40, Table 41 and Table 42 are generic names for a DDR SDRAM interface. For actual pin names refer to Table 1.

3.5.1.1 DDR Interface Is Not Used

Table 40. Connectivity of DDR Related Pins When the DDR Interface Is Not Used

Signal Name	Pin Connection
MDQ[0–63]	NC
MDQS[7–0]	NC
$\overline{\text{MDQS[7–0]}}$	NC
MA[15–0]	NC
MCK[0–2]	NC
$\overline{\text{MCK[0–2]}}$	NC
$\overline{\text{MCS[1–0]}}$	NC
MDM[7–0]	NC
MBA[2–0]	NC
$\overline{\text{MCAS}}$	NC
MCKE[1–0]	NC
MODT[1–0]	NC
MMDIC[1–0]	NC
$\overline{\text{MRAS}}$	NC
$\overline{\text{MWE}}$	NC
MECC[7–0]	NC
MDM8	NC
MDQS8	NC
$\overline{\text{MDQS8}}$	NC
MAPAR_OUT	NC
$\overline{\text{MAPAR\_IN}}$	NC
MVREF[3]	NC
GVDD1/GVDD2[3]	NC

Notes:
1. For the signals listed in this table, the initial M stands for M1 or M2 depending on which DDR controller is not used.
2. If the DDR controller is not used, disable the internal DDR clock by setting the appropriate bit in the System Clock Control Register (SCCR) and put all DDR I/O in sleep mode by setting DRx_GCR[DDRx_DOZE] (for DDR controller x). See the *Clocks* and *General Configuration Registers* chapters in the ***MSC8254 Reference Manual*** for details.
3. For MSC8254 Revision 1 silicon, these pins were connected to GND. For newer revisions of the MSC8254, connecting these pins to GND increases device power consumption.

3.5.1.4 DDR2 Unused MAPAR Pin Connections

When the MAPAR signals are not used, refer to Table 43 to determine the correct pin connections.

Table 43. Connectivity of MAPAR Pins for DDR2

Signal Name	Pin connection
MAPAR_OUT	NC
$\overline{\text{MAPAR\_IN}}$	NC

Notes: **1.** For the signals listed in this table, the initial M stands for M1 or M2 depending on which DDR controller is used for DDR2.
2. For MSC8254 Revision 1 silicon, these pins were connected to GND. For newer revisions of the MSC8254, connecting these pins to GND increases device power consumption.

3.5.2 HSSI-Related Pins

3.5.2.1 HSSI Port Is Not Used

The signal names in Table 44 and Table 45 are generic names for a RapidIO interface. For actual pin names refer to Table 1.

Table 44. Connectivity of Serial RapidIO Interface Related Pins When the RapidIO Interface Is Not Used

Signal Name	Pin Connection
SR_IMP_CAL_RX	NC
SR_IMP_CAL_TX	NC
$\overline{\text{SR[1–2]\_REF\_CLK}}$	SXCVSS
SR[1–2]_REF_CLK	SXCVSS
SR[1–2]_RXD[3–0]	SXCVSS
$\overline{\text{SR[1–2]\_RXD[3–0]}}$	SXCVSS
$\overline{\text{SR[1–2]\_TXD[3–0]}}$	NC
SR[1–2]_TXD[3–0]	NC
SR[1–2]_PLL_AVDD	In use
SR[1–2]_PLL_AGND	In use
SXPVSS	In use
SXCVSS	In use
SXPVDD	In use
SXCVDD	In use

Note: All lanes in the HSSI SerDes should be powered down. Refer to the *MSC8254 Reference Manual* for details.

3.5.2.2 HSSI Specific Lane Is Not Used

Table 45. Connectivity of HSSI Related Pins When Specific Lane Is Not Used

Signal Name	Pin Connection
SR_IMP_CAL_RX	In use
SR_IMP_CAL_TX	In use
$\overline{\text{SR[1–2]\_REF\_CLK}}$	In use
SR[1–2]_REF_CLK	In use